## Search Notes



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10581322

Applicant(s)/Patent Under Reexamination

FUKUI ET AL.

Examiner

Art Unit

Loewe, Sun Jae Y

1626

## SEARCHED Class Subclass Date Examiner

SEARCH NOTES				
Search Notes	Date	Examiner		
restriction requirement	10-30-2007	sl		
stn: registry&caplus	1/15 - 1/16/2008	sl		
palm all inventors	1-16-2008	sl		
STN: registry & caplus updaed	8-18-2008	sl		
PALM all inventors updated	8-18-2008	sl		
STN: registry & caplus updated	5-9-2009	sl		
PALM all inventors updated	5-9-2009	sl		
STN registry&caplus updated	11-21-2009	sl		
PALM all inventors updated	11-21-2009	sl		
STN registry & caplus updated	1-31-2010	sl		
PALM all inventors updated	1-31-2010	sl		
STN registry&caplus updated	6-10-2010	sl		
PALM all inventors updated	6-10-2010	sl		

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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